

Diodes Inc. Material Data Sheet Rev: August 2008

Part Number: BAS16TW-p-F
Weight (mg): 6.37 p=package designator
(HF Date Code 0740+) See Data Sheet

(The Bate Gode 67 401)			Occ Date	Occ Data Officet					
Element	Material Group	Materials	CAS (if applicable)	Average mass homogeneous Materal(%)		Mass (mg)	ppm Homogeneous Material	ppm overall	
Chip	Silicon w/Metal	Doped Silicon*	7440-21-3	100.00%	2.04	0.13	1000000	2038	
Leadframe		Fe	7439-89-6	57.65%	30.84	1.96	576500	17780	
		Ni	7440-02-0	41.00%			410000	12645	
	Alloy 42	Mn	7439-96-5	0.60%			6000	185	
	Alloy 42	Cr(not Cr 6+)	7440-47-3	0.10%			1000	30	
		Co	7440-48-4	0.50%			5000	154	
		Si	7440-21-3	0.15%			1500	46	
Leadframe Plating	Silver	Silver	7440-22-4	100.00%	0.95	0.06	1000000	951	
Bond Wire	Copper Wire	Cu	7440-50-8	100.00%	0.21	0.01	1000000	213	
Encapsulation		SiO2	60676-86-0	87.30%	59.73	3.80	873000	52142	
		Epoxy Resin	29690-82-2	5.00%			50000	2986	
	CEL-1702HF-9	Phenol Resin	26834-02-6	5.00%			50000	2986	
		Aromatic poly-phosphate		2.50%			25000	1493	
		C	1333-86-4	0.20%			2000	119	
Lead Plating Finish	Matte Tin	Tin	7440-31-5	100.00%	6.23	0.40	1000000	6226	
		•		Total	100.00	6.37		100000	

Tolerance ±10%

This data is based on information provided by our suppliers. We believe it to be correct but do not routinely validate it by measurement. It is for guidance only and Diodes Inc. does not guarantee its absolute accuracy or completeness

This product or product family does not contain any of the following substances except as CURRENTLY exempted by ELV II and RoHS and reported above:

Asbestos Antimony Compounds

Azo compounds

Cadmium and cadmium compounds

Certain Shortchain Chlorinated Paraffins

Chlorinated organic compounds

Chlorinated organic compounds Halogens

Hexavalent chromium compounds Lead and lead compounds

Mercury and mercury compounds

REACH SVHCs: Anthracene

4,4'- Diaminodiphenylmethane

Dibutyl phthalate
Cyclododecane
Cobalt dichloride
Diarsenic pentaoxide
Diarsenic trioxide

Sodium dichromate, dihydrate

Organic tin compounds

Ozone Depleting Substances - Class I (CFCs, HBFCs, etc.) Ozone Depleting Substances - Class II (HCFCs)

Perfluorooctane Sulphonate (PFOS) or related compounds
Polybrominated biphenyls (PBB) and Polybrominated diphenyl ethers (PBDE) including DecaBDE

Polychlorinated Biphenyls (PCBs)

Polychlorinated Naphthalenes (> 3 chlorine atoms)

Radioactive Substances

Tributyl Tin (TBT) and Triphenyl Tin (TPT)

Tributyl Tin Oxide (TBTO)

5-tert-butyl-2,4,6-trinitro-m-xylene (musk xylene) Bis (2-ethyl(hexyl)phthalate) (DEHP)

Hexabromocyclododecane (HBCDD)

Alkanes, C10-13, chloro (Short Chain Chlorinated Paraffins)

Bis(tributyltin)oxide Lead hydrogen arsenate Triethyl arsenate Benzyl butyl phthalate

^{*} The Silicon Chip is doped at atomic levels with trace amounts of elements that may include Phosphorus, Boron, Arsenic, and other elements. Metalization may include Titanium, Nickel, Aluminum, Silver or Gold These substances are not reported where their concentration is less than the minimum reportable level per the guidelines specified in the Tables o EIA JIG-101, <u>Material Composition Declaration for Electronic Products</u>.